


<p style="text-align: center;"><b>Search Notes</b></p> 	<p><b>Application/Control No.</b></p> <p>10576311</p>	<p><b>Applicant(s)/Patent Under Reexamination</b></p> <p>MATTHEIJSEN ET AL.</p>
	<p><b>Examiner</b></p> <p>Gary Mui</p>	<p><b>Art Unit</b></p> <p>2416</p>

### SEARCHED

Class	Subclass	Date	Examiner
370	536,535,498,464	11/13/2008	T.N.
455	101,102,103,91	11/13/2008	T.N.
370	203-208,334,535,536,498,464	04/01/2009	GM
375	260,342,343,346-348	04/01/2009	GM
455	101,102,103,91	04/01/2009	GM

### SEARCH NOTES

Search Notes	Date	Examiner
EAST Text Search (US-PGPUB;USPAT;EPO;JPO;IBM_TDB)	11/13/2008	T.N.
EAST Class and Inventor Search (US-PGPUB, USPAT; EPO; JPO; IBM_TDB)	11/13/2008	T.N.
PALM Inventor Search	11/13/2008	T.N.
East Search	04/01/2009	GM
East Search	08/11/2009	GM

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

--	--